PHP/PHU101NQ03LT

N-channel TrenchMOS logic level FET

Rev. 03 — 17 November 2005 Product data sheet

1. Product profile

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology.

1.2 Features

- Logic level threshold
- Low on-state resistance
- Low gate charge

1.3 Applications

- Optimized as a control FET in DC-to-DC converters

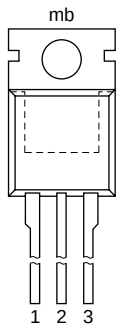
1.4 Quick reference data

- $V_{DS} \leq 30$ V
- $R_{DSon} \leq 5.5$ mΩ
- $I_D \leq 75$ A
- $P_{tot} \leq 166$ W

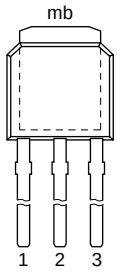
2. Pinning information

Table 1: Pinning

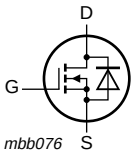
Pin	Description	Simplified outline	Symbol
1	gate (G)		
2	drain (D)		
3	source (S)		
mb	mounting base; connected to drain		



SOT78 (3-lead TO-220AB)



SOT533 (IPAK)



PHILIPS

3. Ordering information

Table 2: Ordering information

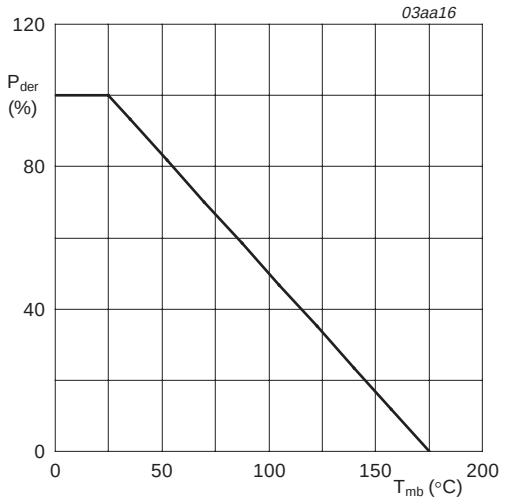
Type number	Package		
	Name	Description	Version
PHP101NQ03LT	SC-46	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78
PHU101NQ03LT	IPAK	plastic single-ended package; 3 leads (in-line)	SOT533

4. Limiting values

Table 3: Limiting values

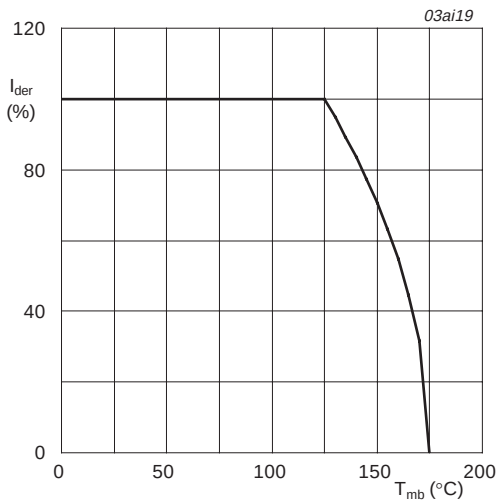
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	25 °C ≤ T_j ≤ 175 °C	-	30	V
V_{DGR}	drain-gate voltage (DC)	25 °C ≤ T_j ≤ 175 °C; R_{GS} = 20 kΩ	-	30	V
V_{GS}	gate-source voltage		-	±20	V
V_{GSM}	peak gate-source voltage	t_p ≤ 50 µs; pulsed; duty cycle = 25 %; T_j ≤ 150 °C	-	±25	V
I_D	drain current	T_{mb} = 25 °C; V_{GS} = 10 V; see Figure 2 and 3	-	75	A
		T_{mb} = 100 °C; V_{GS} = 10 V; see Figure 2	-	75	A
I_{DM}	peak drain current	T_{mb} = 25 °C; pulsed; t_p ≤ 10 µs; see Figure 3	-	240	A
P_{tot}	total power dissipation	T_{mb} = 25 °C; see Figure 1	-	166	W
T_{stg}	storage temperature		–55	+175	°C
T_j	junction temperature		–55	+175	°C
Source-drain diode					
I_S	source current	T_{mb} = 25 °C	-	75	A
I_{SM}	peak source current	T_{mb} = 25 °C; pulsed; t_p ≤ 10 µs	-	240	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	unclamped inductive load; I_D = 43 A; t_p = 0.19 ms; V_{DS} ≤ 15 V; R_{GS} = 50 Ω; V_{GS} = 10 V; starting at T_j = 25 °C	-	185	mJ



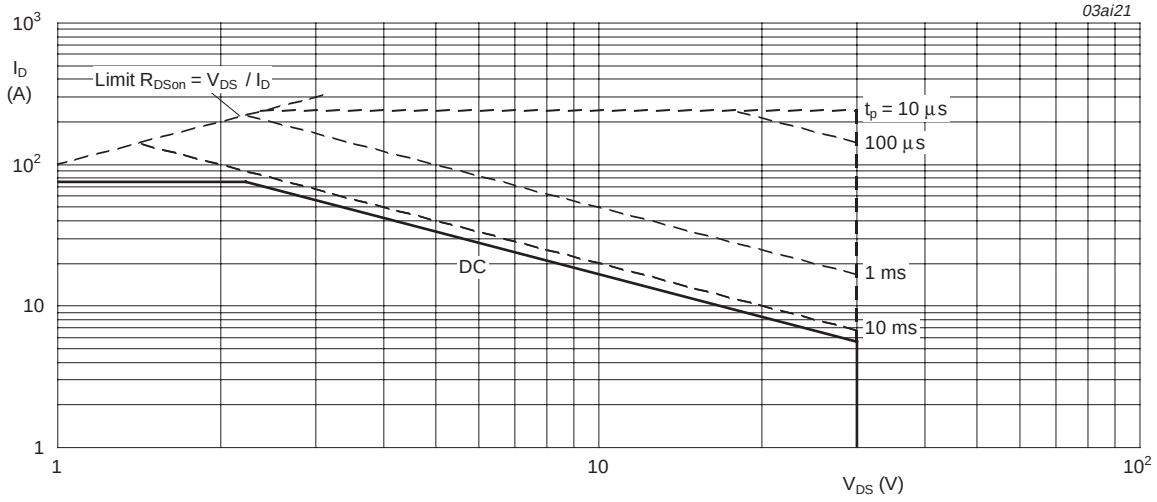
$$P_{der} = \frac{P_{tot}}{P_{tot(25\ ^\circ C)}} \times 100\ \%$$

Fig 1. Normalized total power dissipation as a function of mounting base temperature



$$I_{der} = \frac{I_D}{I_{D(25\ ^\circ C)}} \times 100\ \%$$

Fig 2. Normalized continuous drain current as a function of mounting base temperature



T_{mb} = 25 °C; I_{DM} is single pulse; V_{GS} = 10 V

Fig 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 4: Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting base	see Figure 4	-	-	0.19	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient					
	SOT78	vertical in free air	-	60	-	K/W
	SOT533	vertical in free air	-	70	-	K/W

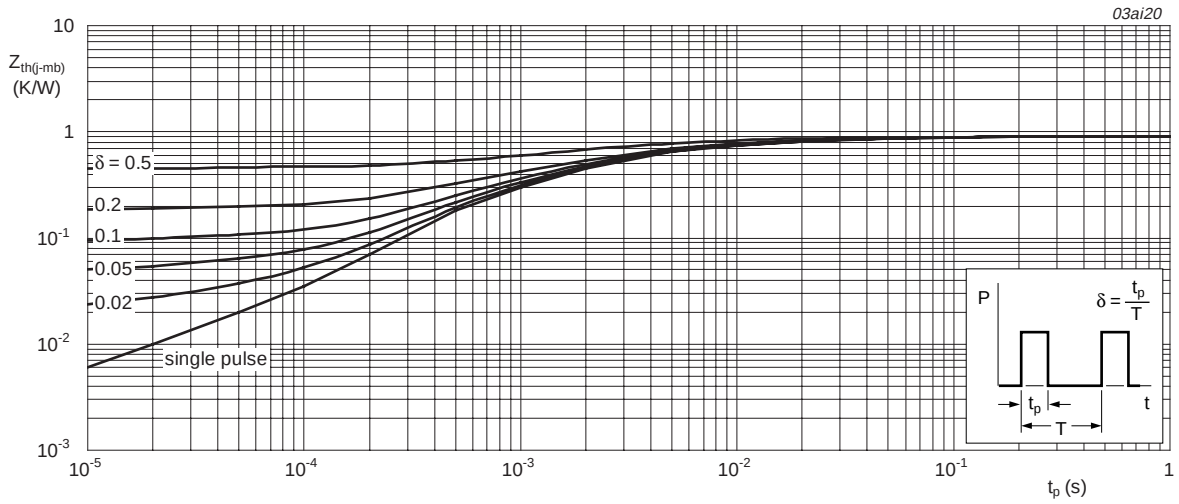


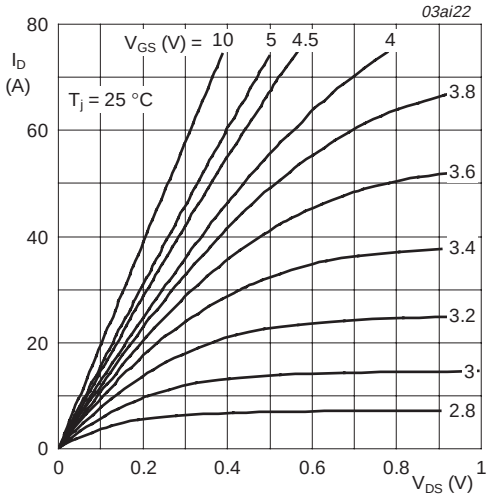
Fig 4. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Characteristics

Table 5: Characteristics

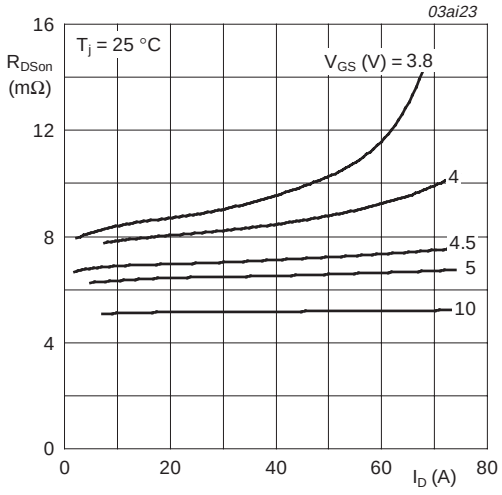
T_j = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 250 µA; V_{GS} = 0 V				
		T_j = 25 °C	30	-	-	V
		T_j = –55 °C	27	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 1 mA; V_{DS} = V_{GS}; see Figure 9 and 10				
		T_j = 25 °C	1	1.9	2.5	V
		T_j = 175 °C	0.6	-	-	V
		T_j = –55 °C	-	-	2.9	V
I_{DSS}	drain leakage current	V_{DS} = 30 V; V_{GS} = 0 V				
		T_j = 25 °C	-	0.05	1	µA
		T_j = 175 °C	-	-	500	µA
I_{GSS}	gate leakage current	V_{GS} = ±20 V; V_{DS} = 0 V	-	10	100	nA
R_{DSon}	drain-source on-state resistance	V_{GS} = 5 V; I_D = 25 A; see Figure 6 and 8				
		T_j = 25 °C	-	5.8	7.5	mΩ
		T_j = 175 °C	-	10.5	13.5	mΩ
		V_{GS} = 10 V; I_D = 25 A; see Figure 6 and 8	-	4.5	5.5	mΩ
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	I_D = 50 A; V_{DS} = 15 V; V_{GS} = 5 V; see Figure 11	-	23	-	nC
Q_{GS}	gate-source charge		-	10.5	-	nC
Q_{GD}	gate-drain charge		-	8	-	nC
C_{iss}	input capacitance	V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz; see Figure 13	-	2180	-	pF
C_{oss}	output capacitance		-	600	-	pF
C_{rss}	reverse transfer capacitance		-	225	-	pF
$t_{d(on)}$	turn-on delay time	V_{DS} = 15 V; I_D = 25 A; V_{GS} = 4.5 V; R_G = 5.6 Ω	-	23	-	ns
t_r	rise time		-	90	-	ns
$t_{d(off)}$	turn-off delay time		-	37	-	ns
t_f	fall time		-	33	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	I_S = 25 A; V_{GS} = 0 V; see Figure 12	-	0.85	1.2	V
t_{rr}	reverse recovery time	I_S = 10 A; dI_S/dt = –100 A/µs; V_{GS} = 0 V	-	37	-	ns
Q_r	recovered charge		-	33	-	nC



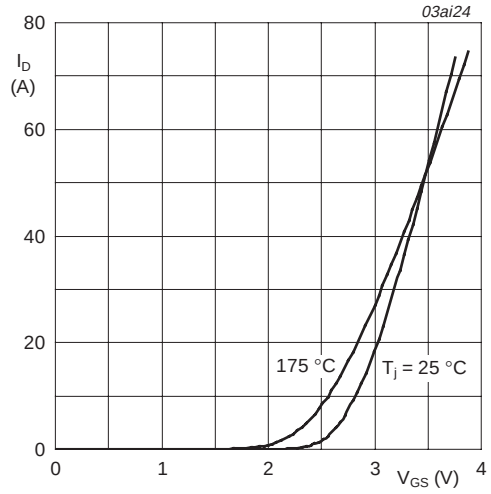
T_j = 25 °C

Fig 5. Output characteristics: drain current as a function of drain-source voltage; typical values



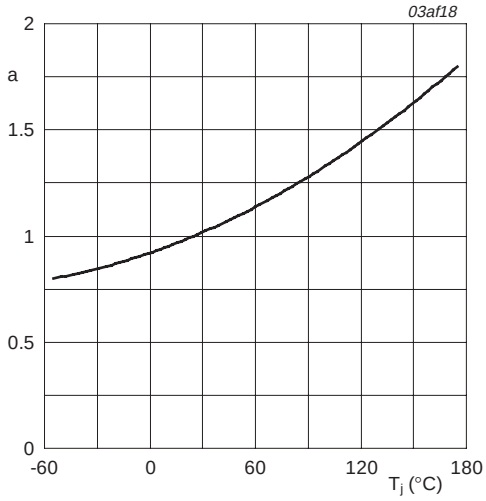
T_j = 25 °C

Fig 6. Drain-source on-state resistance as a function of drain current; typical values



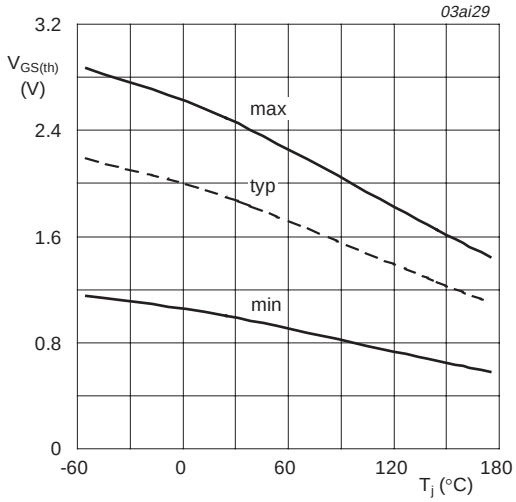
T_j = 25 °C and 175 °C; $V_{DS} > I_D \times R_{DSon}$

Fig 7. Transfer characteristics: drain current as a function of gate-source voltage; typical values



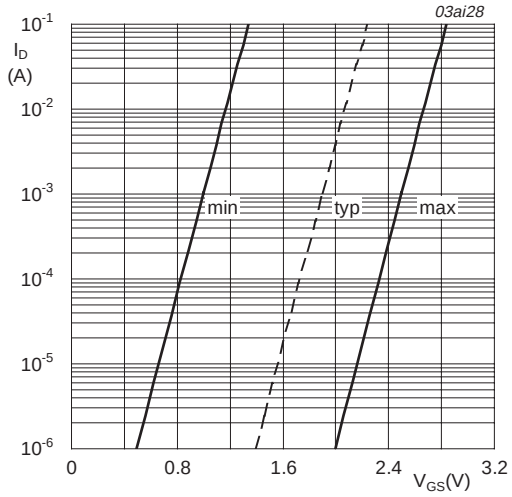
$$a = \frac{R_{DSon}}{R_{DSon(25\ ^\circ C)}}$$

Fig 8. Normalized drain-source on-state resistance factor as a function of junction temperature



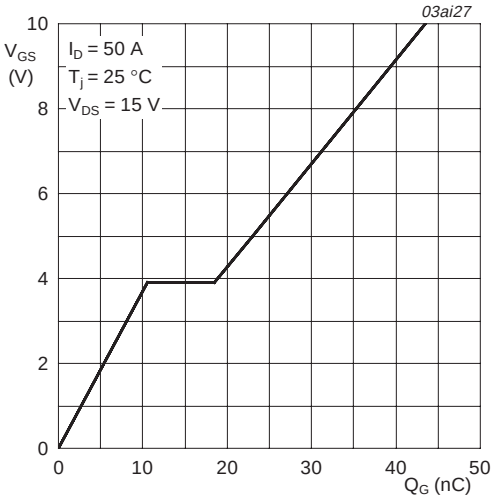
I_D = 1 mA; V_{DS} = V_{GS}

Fig 9. Gate-source threshold voltage as a function of junction temperature



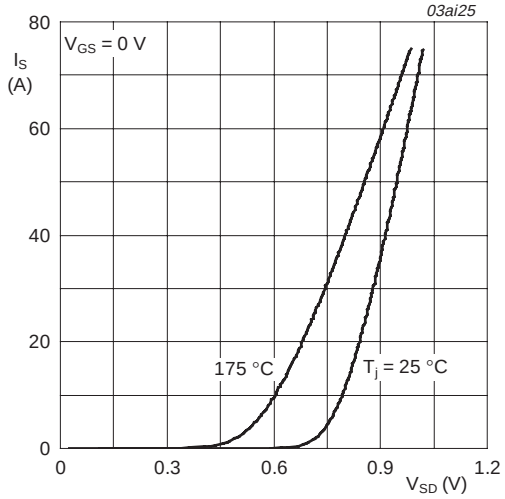
T_j = 25 °C; V_{DS} = 5 V

Fig 10. Sub-threshold drain current as a function of gate-source voltage



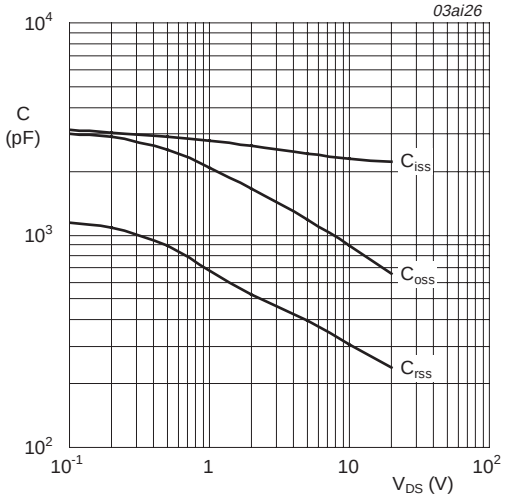
I_D = 50 A; V_{DS} = 15 V

Fig 11. Gate-source voltage as a function of gate charge; typical values



T_j = 25 °C and 175 °C; V_{GS} = 0 V

Fig 12. Source current as a function of source-drain voltage; typical values

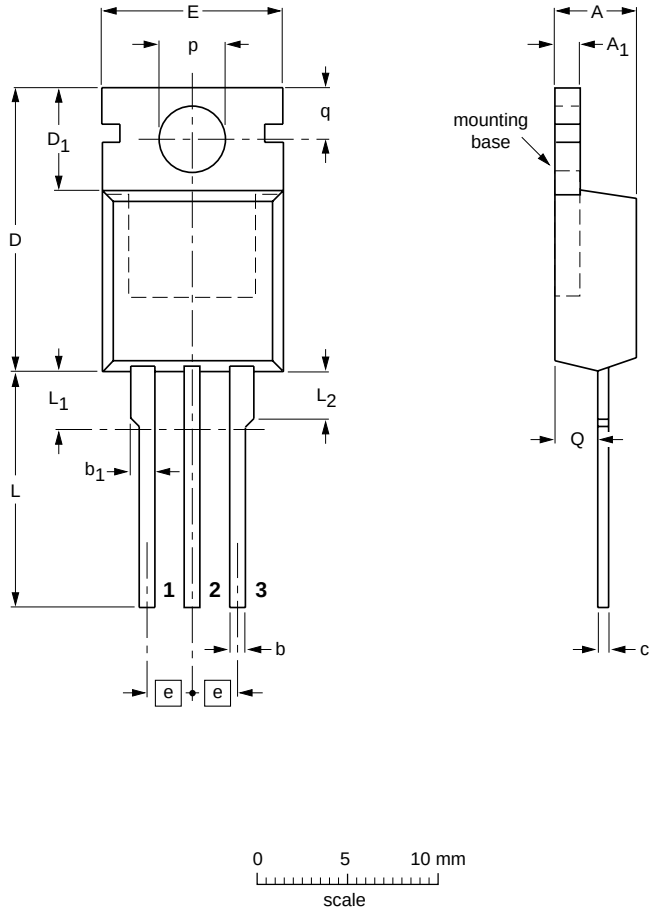


V_{GS} = 0 V; f = 1 MHz

Fig 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB **SOT78**



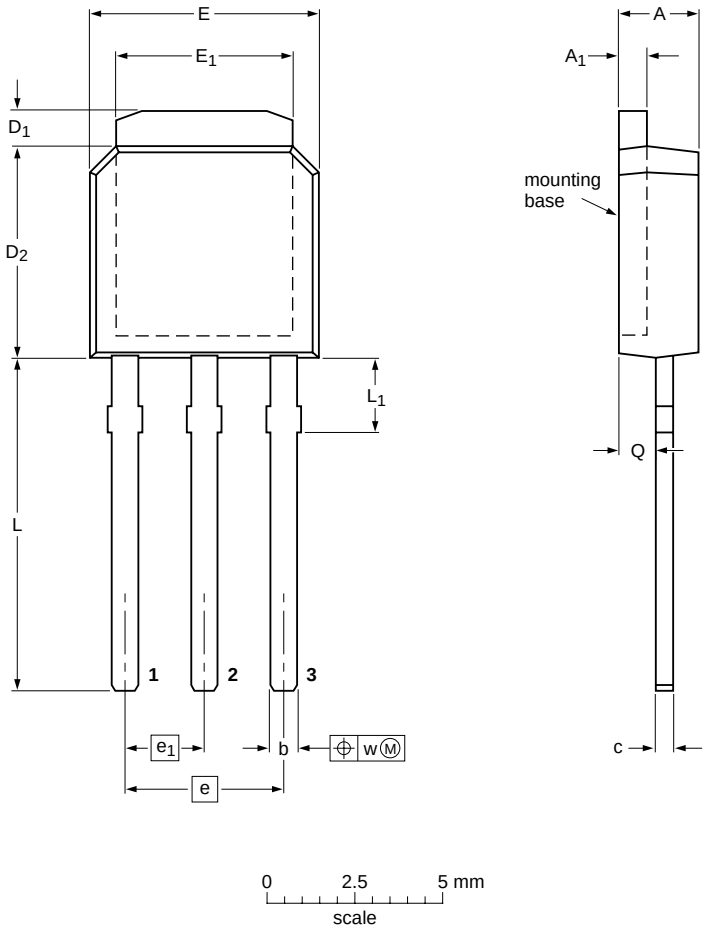
DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	b_1	c	D	D_1	E	e	L	L_1	L_2 max.	p	q	Q
mm	4.7 4.1	1.40 1.25	0.9 0.6	1.45 1.00	0.7 0.4	16.0 15.2	6.6 5.9	10.3 9.7	2.54	15.0 12.8	3.30 2.79	3.0	3.8 3.5	3.0 2.7	2.6 2.2

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT78		3-lead TO-220AB	SC-46			~~05-03-22~~ 05-10-25

Fig 14. Package outline SOT78 (3-lead TO-220AB)

Plastic single-ended package (IPAK); 3 leads (in-line) **SOT533**



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b	c	D_1	D_2	E	E_1	e	e_1	L	L_1 (2) max	Q	w
mm	2.38 2.22	0.89 0.71	0.89 0.71	0.56 0.46	1.10 0.96	6.23 5.97	6.73 6.47	5.21 5.00	4.57 BSC (1)	2.285 BSC (1)	9.6 9.2	2.7	1.1 1.0	0.3

Notes

1. Basic spacing between centers.
2. Terminal dimensions are uncontrolled within zone L_1.

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT533		TO-251				~~04-09-22~~ 05-02-11

Fig 15. Package outline SOT533 (IPAK)

8. Revision history

Table 6: Revision history

Document ID	Release date	Data sheet status	Change notice	Doc. number	Supersedes
PHP_PHU101NQ03LT_3	20051117	Product data sheet	CPCN # 200309016	-	PHP_PHU101NQ03LT-02
Modifications:	• The format of this data sheet has been redesigned to comply with the new presentation and information standard of Philips Semiconductors. • Section 6 “Characteristics”: Increase maximum limit of R_{DSon} at 5 V.				
PHP_PHU101NQ03LT-02	20030225	Product data	-	9397 750 10927	PHP_PHD_PHB_PHU101 NQ03LT-01
PHP_PHD_PHB_PHU101 NQ03LT-01	20020220	Product data	-	9397 750 09307	-

9. Data sheet status

Level	Data sheet status [1]	Product status [2] [3]	Definition
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
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[3] For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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14. Contents

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